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TS3A4741, TS3A4742

SCDS228F-AUGUST 2006-REVISED DECEMBER 2015

# TS3A474x 0.9-Ω Low-Voltage Single-Supply 2-Channel SPST Analog Switches

### 1 Features

- Low ON-State Resistance (Ron)
  - 0.9-Ω Max (3-V Supply)
  - 1.5-Ω Max (1.8-V Supply)
- 0.4-Ω Max R<sub>on</sub> Flatness (3-V Supply)
- 1.6-V to 3.6-V Single-Supply Operation
- Available in SOT-23 and VSSOP Packages
- High Current-Handling Capacity (100 mA Continuous)
- 1.8-V CMOS Logic Compatible (3-V Supply)
- Fast Switching: t<sub>ON</sub> = 14 ns, t<sub>OFF</sub> = 9 ns

## 2 Applications

- Power Routing
- Battery-Powered Systems
- Audio and Video Signal Routing
- Low-Voltage Data-Acquisition Systems
- Communications Circuits
- PCMCIA Cards
- Cellular Phones
- Modems
- Hard Drives

## 3 Description

The TS3A4741 and TS3A4742 are bi-directional, 2channel single-pole/single-throw (SPST) analog switches with low ON-state resistance ( $R_{on}$ ), lowvoltage, that operate from a single 1.6-V to 3.6-V supply. These devices have fast switching speeds, handle rail-to-rail analog signals, and consume very low quiescent power.

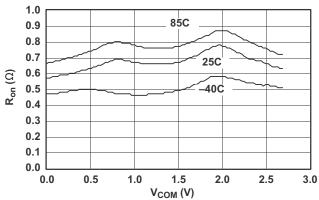
The digital logic input is 1.8-V CMOS compatible when using a single 3-V supply.

The TS3A4741 has two normally open (NO) switches, and the TS3A4742 has two normally closed (NC) switches.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TS3A4741	SOT (8)	2.90 mm × 1.63 mm
	VSSOP (8)	3.00 mm × 3.00 mm
TS3A4742	SOT (8)	2.90 mm × 1.63 mm
153A4742	VSSOP (8)	3.00 mm × 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.



## $R_{on} vs V_{COM} (V_{CC} = 2.7 V)$





## **Table of Contents**

1	Feat	tures 1
2	Арр	lications1
3	Des	cription1
4	Rev	ision History 2
5	Pin	Configuration and Functions 3
6	Spe	cifications 4
	6.1	Absolute Maximum Ratings 4
	6.2	ESD Ratings 4
	6.3	Recommended Operating Conditions 4
	6.4	Thermal Information 4
	6.5	Electrical Characteristics (3-V Supply) 5
	6.6	Electrical Characteristics (1.8-V Supply) 7
	6.7	Typical Characteristics 8
7	Para	ameter Measurement Information 11
8	Deta	ailed Description 14
	8.1	Overview 14

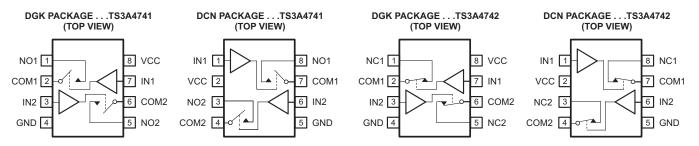
	8.2	Functional Block Diagram	14
	8.3	Feature Description	14
	8.4	Device Functional Modes	14
9	App	lication and Implementation	15
	9.1	Application Information	15
	9.2	Typical Application	15
10	Pow	ver Supply Recommendations	17
11	Lay	out	17
	11.1	Layout Guidelines	17
	11.2	Layout Example	17
12	Dev	ice and Documentation Support	18
	12.1	Related Links	18
	12.2	Trademarks	18
	12.3	Electrostatic Discharge Caution	18
	12.4	Glossary	18
13	Mec	hanical, Packaging, and Orderable	
		mation	18

### **4** Revision History

Changes from Revision E (December 2014) to Revision F	Page
Changed DCN package to clarify switch configuration.	3
<ul> <li>Changed the V<sub>IN</sub> MAX value in the <i>Recommended Operating Conditions</i> table from: 1.8 V to: V<sub>CC</sub></li> </ul>	4
Changes from Revision D (June 2014) to Revision E	Page



# 5 Pin Configuration and Functions



#### **Pin Functions**

	PIN					
NAME	TS3A4	1741	T	S3A4742	I/O	DESCRIPTION
	MSOP	SOT	MSOP	SOT		
COM1	2	7	2	7	I/O	Common
COM2	6	4	6	4	I/O	Common
GND	4	5	4	5	_	Ground
IN1	7	1	7	1	I	Digital control to connect COM to NO or NC
IN2	3	6	3	6	I	Digital control to connect COM to NO or NC
NC1	—	—	1	8	I/O	Normally closed
NC2	—	—	5	3	I/O	Normally closed
NO1	1	8	_	—	I/O	Normally open
NO2	5	3	_	_	I/O	Normally open
VCC	8	2	8	2	I	Power supply

#### TS3A4741, TS3A4742

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### 6 Specifications

### 6.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	V <sub>CC</sub> Supply voltage reference to GND <sup>(2)</sup>		-0.3	4	
V <sub>NO</sub> V <sub>COM</sub> V <sub>IN</sub>	COM Analog and digital voltage		-0.3	V <sub>CC</sub> + 0.3	V
I <sub>NO</sub> I <sub>COM</sub>	On-state switch current	$V_{NO}$ , $V_{COM} = 0$ to $V_{CC}$	-100	100	
I <sub>CC</sub> I <sub>GND</sub>	Continuous current through $V_{CC}$ or $GND$			±100	mA
	Peak current pulsed at 1 ms, 10% duty cycle	COM, V <sub>NO</sub> , V <sub>COM</sub>		±200	
T <sub>A</sub>	Operating temperature Junction temperature		-40	85	
TJ				150	°C
T <sub>stg</sub>	Storage temperature		-65	150	

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Signals on COM or NO exceeding V<sub>CC</sub> or GND are clamped by internal diodes. Limit forward diode current to maximum current rating.

## 6.2 ESD Ratings

			VALUE	UNIT
	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±4000		
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 $^{\left( 2\right) }$	±1000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage reference to ground	1.6	3.6	V
V <sub>NO</sub> V <sub>COM</sub>	Analog voltage	0	3.6	
V <sub>IN</sub>	Digital Voltage	0	$V_{CC}$	

### 6.4 Thermal Information

		TS3A474x	
	THERMAL METRIC <sup>(1)</sup>	DCN/DGK	UNIT
		8 PINS	
		214.8	
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	191.0	
$R_{\theta JB}$	Junction-to-board thermal resistance	113.1	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	52.4	
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	110.2	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



## 6.5 Electrical Characteristics (3-V Supply)<sup>(1)(2)</sup>

 $V_{CC} = 2.7$  V to 3.6 V,  $T_A = -40$  to 85°C,  $V_{IH} = 1.4$  V,  $V_{IL} = 0.5$  V (unless otherwise noted)

	PARAMETER	TEST CONDITION	ONS	TA	MIN	TYP <sup>(3)</sup>	MAX	UNIT	
ANALOG SWIT	СН								
V <sub>COM</sub> , V <sub>NO</sub> , V <sub>NC</sub>	Analog signal range				0		V+	V	
<u> </u>		$V_{CC} = 2.7 \text{ V}, I_{COM} = -10$	00 mA.	25°C		0.7	0.9		
R <sub>on</sub>	ON-state resistance	$V_{NO}$ , $V_{NC} = 1.5$ V	• • • • •	Full			1.1	Ω	
40	ON-state resistance match between	$V_{CC} = 2.7 \text{ V}, I_{COM} = -10$	00 mA,	25°C		0.03	0.05	0	
ΔR <sub>on</sub>	channels <sup>(4)</sup>	$V_{NO}, V_{NC} = 1.5 V$		Full			0.15	Ω	
D		$V_{CC} = 2.7 \text{ V}, I_{COM} = -100 \text{ mA},$		25°C		0.23	0.4		
R <sub>on(flat)</sub>	ON-state resistance flatness <sup>(5)</sup>	$V_{\rm NO}, V_{\rm NC} = 1 \text{ V}, 1.5 \text{ V}, 2$	2 V	Full			0.5	Ω	
	NO	$V_{CC} = 3.6 \text{ V}, \text{ V}_{COM} = 0.3$	3 V, 3 V,	25°C	-2	1	2	~^	
NO(OFF)	OFF leakage current <sup>(6)</sup>	$V_{CC} = 3.6 \text{ V}, V_{COM} = 0.3 \text{ V}, 3 \text{ V},$ $V_{NO} = 3 \text{ V}, 0.3 \text{ V}$		Full	-18		18	nA	
1	СОМ	$V_{\rm CC} = 3.6 \text{ V}, V_{\rm COM} = 0.3$	3 V, 3 V,	25°C	-2	1	2	~ ^	
COM(OFF)	OFF leakage current <sup>(6)</sup>	$V_{NO} = 3 V, 0.3 V$		Full	-18		18	nA	
	СОМ	$V_{CC} = 3.6 \text{ V}, V_{COM} = 0.3$	3 V, 3 V,	25°C	-2.5	0.01	2.5	~ ^	
ICOM(ON)	ON leakage current <sup>(6)</sup>	$V_{NO} = 0.3 V, 3 V, or floa$	ting	Full	-5		5	nA	
DYNAMIC									
•	Turn-on time	$V_{NO}, V_{NC} = 1.5 V, R_{L} =$	50 Ω,	25°C		5	14	-	
t <sub>ON</sub>	rum-on ume	$C_L = 35 \text{ pF}$ , See Figure	14	Full			15	ns	
	Turn off time	$V_{NO}, V_{NC} = 1.5 V, R_{L} =$	50 Ω,	25°C		4	9		
tOFF	Turn-off time	$C_L = 35 \text{ pF}$ , See Figure	14	Full			10	ns	
Q <sub>C</sub>	Charge injection	$V_{GEN} = 0$ , $R_{GEN} = 0$ , $C_L = 1$ nF, See Figure 15		25°C		3		рС	
C <sub>NO(OFF)</sub>	NO OFF capacitance	f = 1 MHz, See Figure 16		25°C		23			
C <sub>COM(OFF)</sub>	COM OFF capacitance	f = 1 MHz, See Figure 1	6	25°C		20		pF	
C <sub>COM(ON)</sub>	COM ON capacitance	f = 1 MHz, See Figure 1	6	25°C		43			
BW	Bandwidth	$R_L = 50 \Omega$ , Switch ON		25°C		125		MHz	
0	OFF isolation <sup>(7)</sup>	$R_{L} = 50 \Omega, C_{L} = 5 pF,$	f = 10 MHz	25%		-40			
O <sub>ISO</sub>	OFF Isolation (	See Figure 17 f :	f = 1	25°C		-62		dB	
			MHz			02			
		$\mathbf{P} = 50.0  \mathbf{C} = 5  \mathrm{pF}$	f = 10 MHz			-73			
X <sub>TALK</sub>	Crosstalk	$R_L = 50 \Omega, C_L = 5 pF,$ See Figure 17	f = 1	25°C				dB	
			MHz			-95			
TUD	Total bases of a flat offer	f = 20 Hz to 20 kHz,	R <sub>L</sub> = 32 Ω	0500		0.04%			
THD	Total harmonic distortion	$V_{\text{COM}} = 2 V_{\text{P-P}} \qquad $		25°C		0.003%			
DIGITAL CONT	ROL INPUTS (IN1, IN2)								
V <sub>IH</sub>	Input logic high			Full	1.4				
V <sub>IL</sub>	Input logic low			Full			0.5	V	
				25°C		0.5	1		
I <sub>IN</sub>	Input leakage current	$V_{I} = 0 \text{ or } V_{CC}$		Full	-20		20	nA	
SUPPLY		J.		ı					

The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum. (1)

Parts are tested at 85°C and specified by design and correlation over the full temperature range. (2)

(3) Typical values are at  $V_{CC} = 3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

(4)  $\Delta R_{on} = R_{on(max)} - R_{on(min)}$ (5) Flatness is defined as the difference between the maximum and minimum value of  $r_{on}$  as measured over the specified analog signal ranges.

Leakage parameters are 100% tested at the maximum-rated hot operating temperature and specified by correlation at  $T_A = 25^{\circ}$ C. OFF isolation =  $20_{log}10$  ( $V_{COM}/V_{NO}$ ),  $V_{COM}$  = output,  $V_{NO}$  = input to OFF switch (6)

(7)

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EXAS

# **Electrical Characteristics (3-V Supply)**<sup>(1)(2)</sup> (continued)

 $V_{CC}$  = 2.7 V to 3.6 V,  $T_A$  = -40 to 85°C,  $V_{IH}$  = 1.4 V,  $V_{IL}$  = 0.5 V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	TA	MIN	TYP <sup>(3)</sup>	MAX	UNIT
V <sub>CC</sub>	Power-supply range			2.7		3.6	V
		25°C			0.075		
ICC	I <sub>CC</sub> Positive-supply current	$V_{CC} = 3.6 \text{ V}, \text{ V}_{IN} = 0 \text{ or } V_{CC}$	Full			0.75	μA



## 6.6 Electrical Characteristics (1.8-V Supply)<sup>(1) (2)</sup>

 $V_{CC}$  = 1.65 V to 1.95 V,  $T_A$  = -40 to 85°C,  $V_{IH}$  = 1 V,  $V_{IL}$  = 0.4 V (unless otherwise noted)

	PARAMETER	TEST COND	ITIONS	TA	MIN	TYP <sup>(2)</sup>	MAX	UNIT
ANALOG S	WITCH							
V <sub>COM</sub> , V <sub>NO</sub> , V <sub>NC</sub>	Analog signal range				0		V+	V
R <sub>on</sub>	ON-state resistance	$V_{CC} = 1.8 \text{ V}, I_{COM} = -10 \text{ V}_{NO}, V_{NC} = 0.9 \text{ V}$	) mA,	25 °C Full		1	1.5 2	Ω
ΔR <sub>on</sub>	ON-state resistance match between	$V_{\rm CC} = 1.8 \text{ V}, I_{\rm COM} = -10$	) mA,	25 °C		0.09	0.15	Ω
011	channels <sup>(1)</sup>	$V_{NO}, V_{NC} = 0.9 V$		Full			0.25	
R <sub>on(flat)</sub>	ON-state resistance flatness <sup>(3)</sup>	$V_{CC} = 1.8 \text{ V}, I_{COM} = -10 \text{ O} \le V_{NO}, V_{NC} \le V_{CC}$	) mA,	25 °C Full		0.7	0.9 1.5	Ω
	NO	$V_{\rm CC} = 1.95 \text{ V}, \text{ V}_{\rm COM} = 0$	15 V 1 65 V	25 °C	-1	0.5	1	
I <sub>NO(OFF)</sub>	OFF leakage current <sup>(4)</sup>	$V_{\rm CC} = 1.93$ V, $V_{\rm COM} = 0$ $V_{\rm NO} = 1.8$ V, 0.15 V	.15 V, 1.05 V,	Full	-10		10	nA
	СОМ	$V_{\rm CC} = 1.95 \text{ V}, \text{ V}_{\rm COM} = 0$	0.15 V. 1.65 V.	25 °C	-1	0.5	1	
I <sub>COM(OFF)</sub>	OFF leakage current <sup>(4)</sup>	$V_{NO}$ , = 1.8 V, 0.15 V		Full	-10		10	nA
	СОМ	$V_{CC} = 1.95 \text{ V}, \text{ V}_{COM} = 0$	0.15 V, 1.65 V,	25 °C	-1	0.01	1	nA
ICOM(ON)	ON leakage current <sup>(4)</sup>	V <sub>NO</sub> = 0.15 V, 1.65 V, or		Full	-3		3	ΠA
DYNAMIC								
tau	Turn-on time	$V_{NO}, V_{NC} = 1.5 V, R_{L} =$	50 Ω,	25 °C		6	18	ns
t <sub>ON</sub>	rum-on ume	$C_L = 35 \text{ pF}$ , See Figure	14	Full			20	115
toff	Turn-off time	$V_{NO}, V_{NC} = 1.5 V, R_{L} =$		25 °C		5	10	ns
OFF		$C_L = 35 \text{ pF}, \text{ See Figure}$	14	Full			12	110
Q <sub>C</sub>	Charge injection	$V_{GEN} = 0, R_{GEN} = 0, C_L$ See Figure 15	= 1 nF,	25 °C		3.2		рС
C <sub>NO(OFF)</sub>	NO OFF capacitance	f = 1 MHz, See Figure 1	6	25 °C		23		
C <sub>COM(OFF)</sub>	COM OFF capacitance	f = 1 MHz, See Figure 1	6	25 °C		20		pF
C <sub>COM(ON)</sub>	COM ON capacitance	f = 1 MHz, See Figure 1	6	25 °C		43		
BW	Bandwidth	$R_L = 50 \Omega$ , Switch ON		25 °C		123		MHz
O <sub>ISO</sub>	OFF isolation <sup>(5)</sup>	$R_L = 50 \Omega$ , $C_L = 5 pF$ , See Figure 17	f = 10 MHz f = 100 MHz	− 25 °C		-61 -36		dB
X <sub>TALK</sub>	Crosstalk	$R_L = 50 \Omega, C_L = 5 pF,$ See Figure 17	f = 10 MHz	25 °C		-95		dB
			f = 100 MHz			-73 0.14%		
THD	Total harmonic distortion	f = 20 Hz to 20 kHz, V <sub>COM</sub> = 2 V <sub>P-P</sub>	$R_{L} = 32 \Omega$ $R_{L} = 600 \Omega$	− 25 °C		0.013%		•
DIGITAL CO	ONTROL INPUTS (IN1, IN2)		4	1 1				L
V <sub>IH</sub>	Input logic high			Full	1			
V <sub>IL</sub>	Input logic low			Full			0.4	V
I <sub>IN</sub>	Input leakage current	$V_{I} = 0 \text{ or } V_{CC}$		25 °C Full	-10	0.1	5 10	nA
SUPPLY					10		10	L
V <sub>cc</sub>	Power-supply range				1.65		1.95	V
				25 °C			0.05	-
I <sub>CC</sub>	Positive-supply current	$V_I = 0 \text{ or } V_{CC}$		Full			0.5	μA

 ΔR<sub>on</sub> = R<sub>on(max)</sub> - R<sub>on(min)</sub>
 Typical values are at T<sub>A</sub> = 25°C.
 Flatness is defined as the difference between the maximum and minimum value of r<sub>on</sub> as measured over the specified analog signal ranges.

Leakage parameters are 100% tested at the maximum-rated hot operating temperature and specified by correlation at  $T_A = 25^{\circ}C$ . OFF isolation =  $20_{log}10$  ( $V_{COM}/V_{NO}$ ),  $V_{COM}$  = output,  $V_{NO}$  = input to OFF switch (4)

(5)

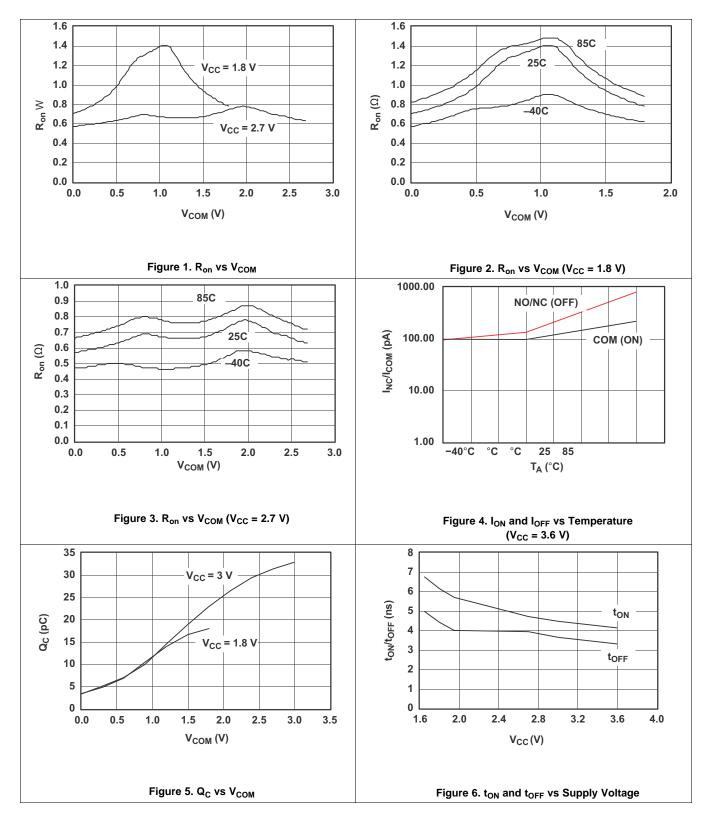
#### TS3A4741, TS3A4742

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TEXAS INSTRUMENTS

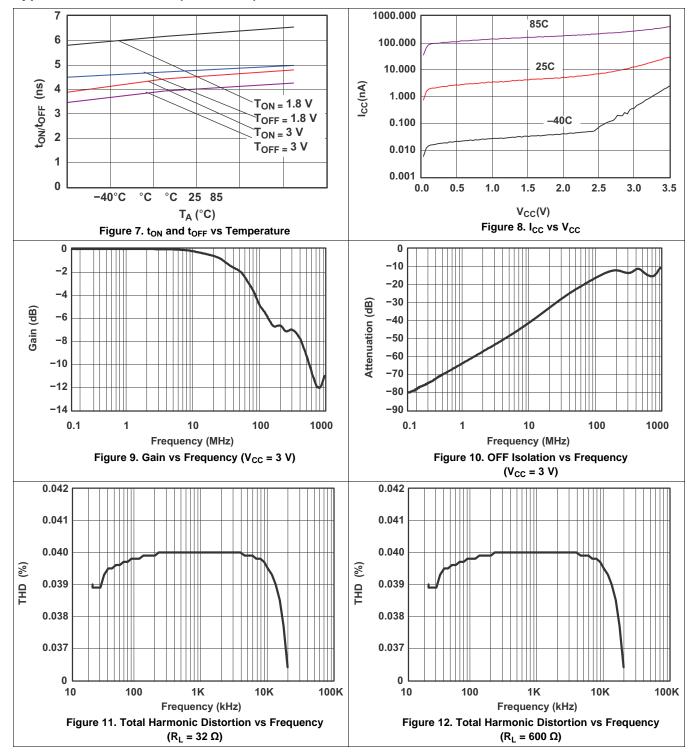
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### 6.7 Typical Characteristics





#### **Typical Characteristics (continued)**

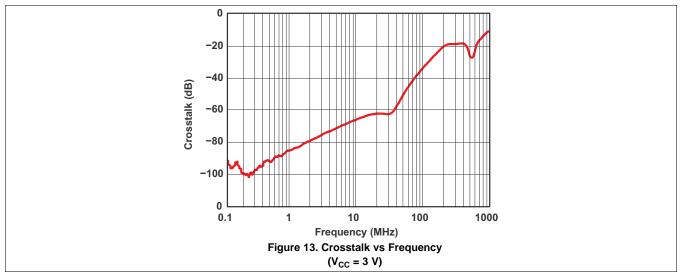


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TEXAS INSTRUMENTS

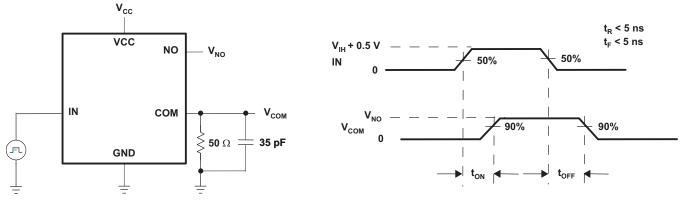
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## **Typical Characteristics (continued)**

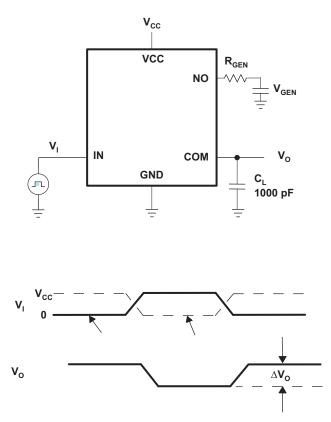




## 7 Parameter Measurement Information



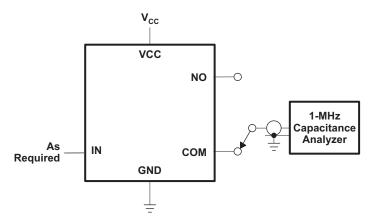




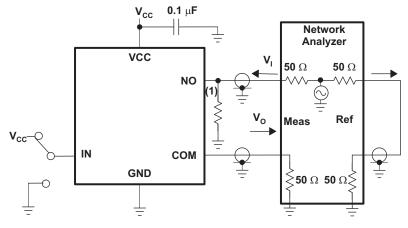


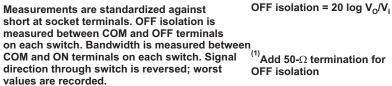


#### **Parameter Measurement Information (continued)**





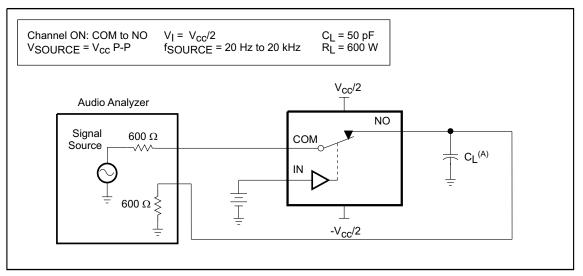








### **Parameter Measurement Information (continued)**



A. C<sub>L</sub> includes probe and jig capacitance.



### 8 Detailed Description

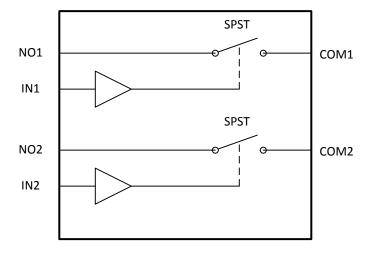
#### 8.1 Overview

The TS3A4741 and TS3A4742 are bi-directional, 2-channel single-pole/single-throw (SPST) analog switches with low ON-state resistance ( $R_{on}$ ), low-voltage, that operate from a single 1.6-V to 3.6-V supply. These devices have fast switching speeds, handle rail-to-rail analog signals, and consume very low quiescent power.

The digital logic input is 1.8-V CMOS compatible when using a single 3-V supply.

The TS3A4741 has two normally open (NO) switches, and the TS3A4742 has two normally closed (NC) switches.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

The TS3A4741 and TS3A4742 has a low on resistance and high current handling capability up to 100 mA continuous current so it can be used for power sequencing and routing with minimal losses. The switch is also bidirectional with fast switching times in the 10 ns range which allows data acquisition and communication between multiple devices.

With a 3-V supply these devices are compatible with standard 1.8-V CMOS logic.

### 8.4 Device Functional Modes

#### Table 1. Function Table

IN	NO to COM, COM to NO (TS3A4741)	NC to COM, COM to NC (TS3A4742)
L	OFF	ON
Н	ON	OFF



### 9 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 Application Information

Analog signals that range over the entire supply voltage ( $V_{CC}$  to GND) of the TS3A4741 and TS3A4742 can be passed with very little change in  $R_{on}$  (see *Typical Characteristics*). The switches are bidirectional, so the NO, NC, and COM pins can be used as either inputs or outputs.

### 9.2 Typical Application

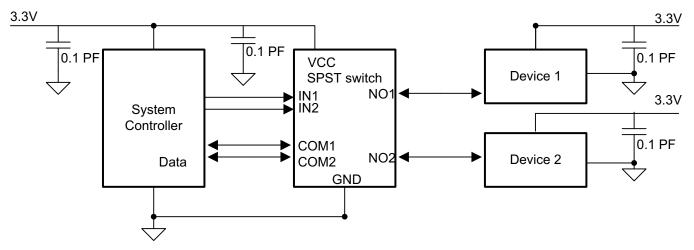


Figure 19. Typical Application Schematic

#### 9.2.1 Design Requirements

Ensure that all of the signals passing through the switch are within the specified ranges to ensure proper performance.

#### 9.2.2 Detailed Design Procedure

The TS3A474x can be properly operated without any external components. However, TI recommends that unused pins should be connected to ground through a 50- $\Omega$  resistor to prevent signal reflections back into the device. TI also recommends that the digital control pins (INx) be pulled up to V<sub>CC</sub> or down to GND to avoid undesired switch positions that could result from the floating pin.



## **Typical Application (continued)**

### 9.2.3 Application Curve

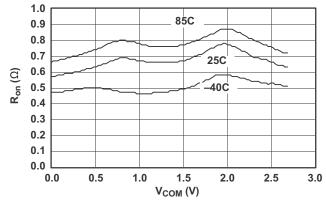


Figure 20.  $R_{on}$  vs  $V_{COM}$  ( $V_{CC}$  = 2.7 V)



### **10** Power Supply Recommendations

Proper power-supply sequencing is recommended for all CMOS devices. Do not exceed the absolute maximum ratings, because stresses beyond the listed ratings can cause permanent damage to the device. Always sequence VCC on first, followed by NO, NC, or COM.

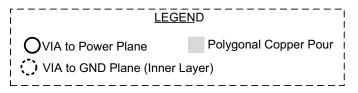
Although it is not required, power-supply bypassing improves noise margin and prevents switching noise propagation from the VCC supply to other components. A  $0.1-\mu$ F capacitor, connected from VCC to GND, is adequate for most applications.

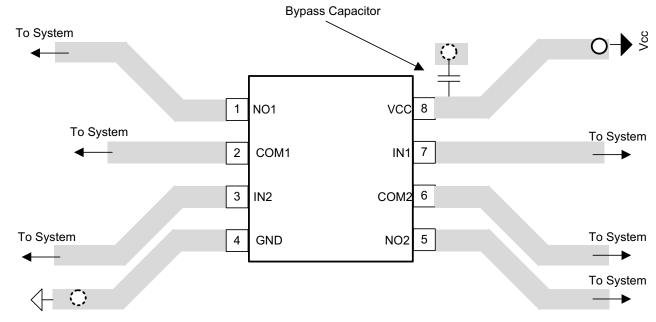
### 11 Layout

#### 11.1 Layout Guidelines

High-speed switches require proper layout and design procedures for optimum performance. Reduce stray inductance and capacitance by keeping traces short and wide. Ensure that bypass capacitors are as close to the device as possible. Use large ground planes where possible.

### 11.2 Layout Example







#### TEXAS INSTRUMENTS

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### **12 Device and Documentation Support**

#### 12.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TS3A4741	Click here	Click here	Click here	Click here	Click here
TS3A4742	Click here	Click here	Click here	Click here	Click here

#### Table 2. Related Links

### 12.2 Trademarks

All trademarks are the property of their respective owners.

### 12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 12.4 Glossary

#### SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

### 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TS3A4741DCNR	ACTIVE	SOT-23	DCN	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(8BLO ~ 8BLR)	Samples
TS3A4741DGKR	ACTIVE	VSSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	JYR	Samples
TS3A4742DCNR	ACTIVE	SOT-23	DCN	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	8BPR	Samples
TS3A4742DGKR	ACTIVE	VSSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	L7R	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



17-Mar-2015

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# PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3A4741DCNR	SOT-23	DCN	8	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
TS3A4741DGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TS3A4742DCNR	SOT-23	DCN	8	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
TS3A4742DGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

17-Mar-2015



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS3A4741DCNR	SOT-23	DCN	8	3000	202.0	201.0	28.0
TS3A4741DGKR	VSSOP	DGK	8	2500	358.0	335.0	35.0
TS3A4742DCNR	SOT-23	DCN	8	3000	202.0	201.0	28.0
TS3A4742DGKR	VSSOP	DGK	8	2500	358.0	335.0	35.0

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

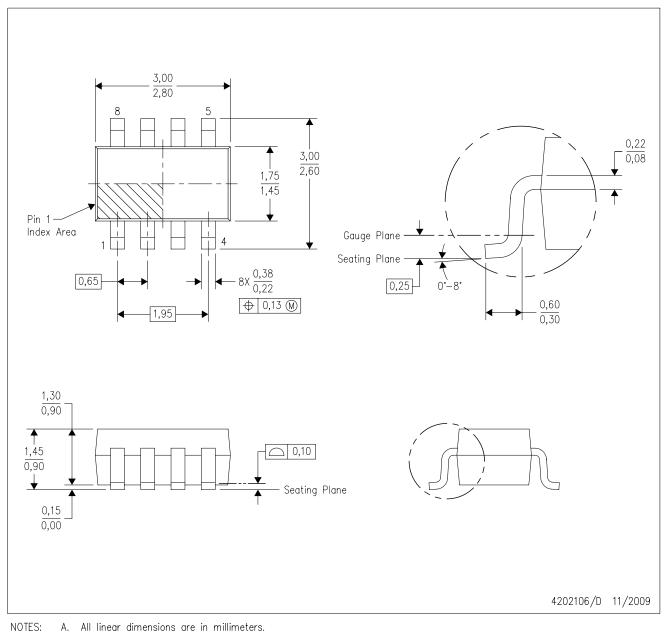
Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.

- D Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



DCN (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



- A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.
- C. Package outline exclusive of metal burr & dambar protrusion/intrusion.
- D. Package outline inclusive of solder plating.
- E. A visual index feature must be located within the Pin 1 index area.
- F. Falls within JEDEC MO-178 Variation BA.
- G. Body dimensions do not include flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.





- NOTES: A. All linear dimensions are in millimeters. B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers D. should contact their board assembly site for stencil design recommendations. Refer to IPC-7525.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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